## Search Notes



| Application/Control No. | Applicant(s)/Patent Under Reexamination |  |
|-------------------------|---|--|
| 10645434                | CHANG ET AL.                            |  |
| Examiner                | Art Unit                                |  |
| Bayat, Ali              | 2624                                    |  |

| SEARCHED |                         |         |          |  |  |  |
|----------|-------------------------|---------|----------|--|--|--|
| Class    | Subclass                | Date    | Examiner |  |  |  |
| 382      | 232,233,250,251,253,268 | 6/06/07 | A.B      |  |  |  |
| 375      | 240.2,240.03,240.29     | 6/06/07 | A.B      |  |  |  |
| 358      | 1.9,426.14              | 6/06/07 | A.B      |  |  |  |

| SEARCH NOTES   |         |          |  |  |
|--|---------|----------|--|--|
| Search Notes   | Date    | Examiner |  |  |
| EAST (USPAT; USPGPUB; EPO;JPO;DERWENT; IBM-TDB) See text search history print out. | 6/06/07 | A.B      |  |  |

| INTERFERENCE SEARCH |  |         |          |  |  |  |
|---------------------|--|---------|----------|--|--|--|
| Class               | Subclass                                   | Date    | Examiner |  |  |  |
| USPGPUB             | See Interference search history print out. | 6/06/07 | A.B      |  |  |  |

U.S. Patent and Trademark Office Part of Paper No.: 20070607